

Features

- 3rd generation SiC MOSFET technology
- Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_{rr})
- Halogen free, RoHS compliant

Benefits

- Reduce switching losses and minimize gate ringing
- · Higher system efficiency
- · Reduce cooling requirements
- Increase power density
- Increase system switching frequency

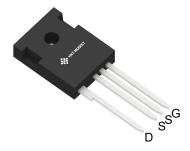
Applications

- Renewable energy
- EV battery chargers
- High voltage DC/DC converters
- Switch Mode Power Supplies

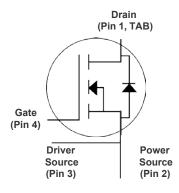




Ordering Part Number	Package	Qty(PCS)
MSC040SMA120B4	TO-247-4L	30



TO-247-4L



Maximum Ratings (T_c = 25 °C unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions
V_{DSmax}	Drain - Source Voltage	1200	V	$V_{GS} = 0 \text{ V}, I_{D} = 100 \mu\text{A}$
V_{GSmax}	Gate - Source Voltage (dynamic)	-10/+25	V	AC (f >1 Hz)
V_{GSop}	Gate - Source Voltage (static)	-5/+20	٧	Static
			Α	V _{GS} = 15 V, T _C = 25°C
I _D Continuous Drain Curren	Continuous Diam Current	57	A	V _{GS} = 15 V, T _C = 100°C
I _{D(pulse)}	Pulsed Drain Current	TBD	А	Pulse width t _P limited by T _{jmax}
P_{D}	Power Dissipation	405	W	T _c =25°C, T _J = 175 °C
T_{J} , T_{stg}	Operating Junction and Storage Temperature	-40 to +175	°C	
T _L	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s

MSC040SMA120B4

Electrical Characteristics (T_C = 25°C unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
V _{(BR)DSS}	Drain-Source Breakdown Voltage	1200			V	V _{GS} = 0 V, I _D = 100 μA	
\/	V Cata Threahald Valtage	2.0	2.5	4.0	V	$V_{DS} = V_{GS}$, $I_D = 10 \text{ mA}$	
V _{GS(th)}	V _{GS(th)} Gate Threshold Voltage		1.5		V	$V_{DS} = V_{GS}, I_{D} = 10 \text{ mA}, T_{J} = 175^{\circ}\text{C}$	Fig. 11
I _{DSS}	Zero Gate Voltage Drain Current		1	50	μA	V _{DS} = 1200 V, V _{GS} = 0 V	
I _{GSS}	Gate-Source Leakage Current		10	200	nA	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	
		-200	-10		nA	$V_{GS} = -10 \text{ V}, V_{DS} = 0 \text{ V}$	
R	Drain-Source On-State Resistance		40	50	mΩ	V _{GS} = 20 V, I _D = 40 A	Fig. 4,
R _{DS(on)}	Brain-oddree on-otate resistance		59		11152	V _{GS} = 20 V, I _D = 40 A, T _J = 175°C	5, 6
g _{fs}	Transconductance		10.4		S	V _{DS} = 20 V, I _{DS} = 40 A	Fig. 7
9fs	Transconductance		7.7			V _{DS} = 20 V, I _{DS} = 40 A, T _J = 175°C	
C_{iss}	Input Capacitance		2101			., .,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	
C_{oss}	Output Capacitance		161		pF	$V_{GS} = 0 \text{ V}, V_{DS} = 1000 \text{ V}$ f=100kHz	Fig. 17, 18
C_{rss}	Reverse Transfer Capacitance		14]	V _{AC} = 25 mV	
Eoss	Coss Stored Energy		90		μJ		Fig. 16
Eon	Turn-On Switching Energy (SiC Diode FWD)		1100			$V_{DS} = 800 \text{ V}, V_{GS} = -5 \text{ V}/+20 \text{ V}, I_{D} = 40 \text{ A}$, _{Eim} 06
E _{OFF}	Turn Off Switching Energy (SiC Diode FWD)		900		μJ	$R_{G(ext)} = 2.5\Omega$, L= 100 μ H, Tj = 175°C	Fig. 26
$t_{d(on)}$	Turn-On Delay Time		22				
t _r	Rise Time		49			V_{DD} = 800 V, V_{GS} = -5 V/20 V $R_{G(ext)}$ = 2.5 Ω , I_{D} = 40 A Timing relative to V_{DS}	Fig. 27
$t_{\text{d(off)}}$	Turn-Off Delay Time		71		ns		
t _f	Fall Time		23		1		
R _{G(int)}	Internal Gate Resistance		1.7		Ω	f = 1 MHz, V _{AC} = 25 mV	
Q_{gs}	Gate to Source Charge		33			V _{DS} = 800 V, V _{GS} = -5 V/20 V	
Q_{gd}	Gate to Drain Charge		51		$nC I_D = 40 \text{ A}$,	Fig. 12
Q_g	Total Gate Charge		131				

Reverse Diode Characteristics (T_c = 25°C unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
\/	Diode Forward Voltage	4.1		V	V _{GS} = -5 V, I _{SD} = 20 A, T _J = 25 °C	Fig. 8,
V _{SD}	Diode Porward Voltage	3.5		V	V _{GS} = -5 V, I _{SD} = 20 A, T _J = 175 °C	9, 10
Is	Continuous Diode Forward Current		83	А	V _{GS} = -4 V, T _C = 25°C	Note 1
I _{S, pulse}	Diode pulse Current		TBD	А	$V_{GS} = -4 \text{ V}$, pulse width t_P limited by T_{jmax}	Note 1
t _{rr}	Reverse Recover time	56		ns		
Q _r	Reverse Recovery Charge	508		nC	$V_{GS} = -5 \text{ V}, I_{SD} = 40 \text{ A}, V_{R} = 800 \text{ V}$ $dif/dt = 2250 \text{ A}/\mu\text{s}, T_{I} = 175 \text{ °C}$	Note 1
I _{rrm}	Peak Reverse Recovery Current	18		А	. ,	

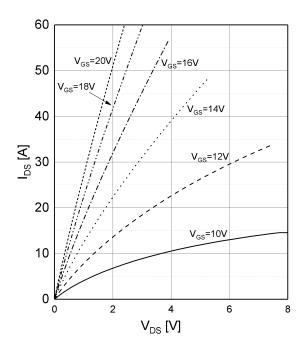
Thermal Characteristics

Symbo	I Parameter	Тур.	Unit	Test Conditions	Note
Rejc	Thermal Resistance from Junction to Case	0.25			Fig. 24
R _{eJA}	Thermal Resistance From Junction to Ambient	40	°C/W		Fig. 21

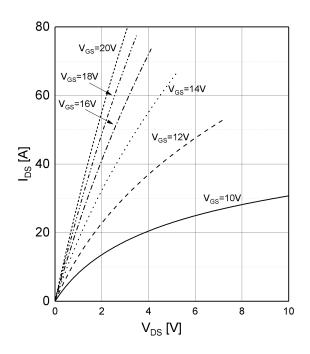


Typical Characteristics

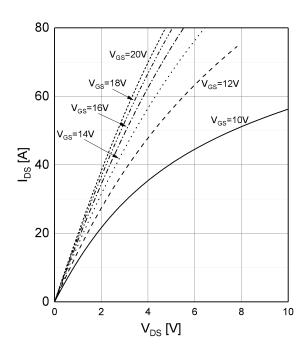
Output characteristics $I_{DS}=f(V_{DS})$, $T_{J}=-55$ °C



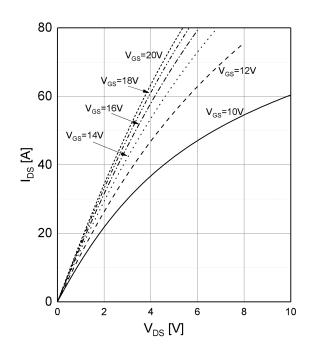
Output characteristics I_{DS}=f(V_{DS}), T_J=25°C



Output characteristics $I_{DS}=f(V_{DS})$, $T_J=150$ °C

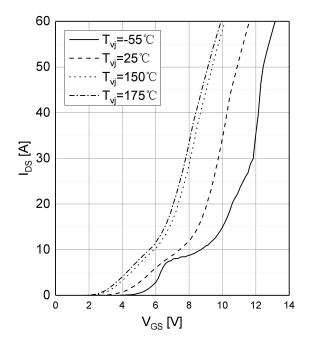


Output characteristics I_{DS}=f(V_{DS}), T_J=175°C

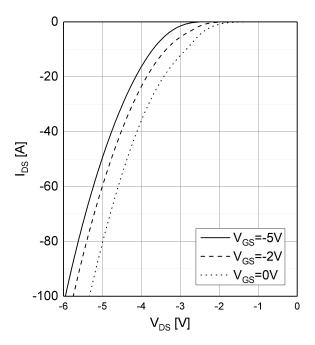




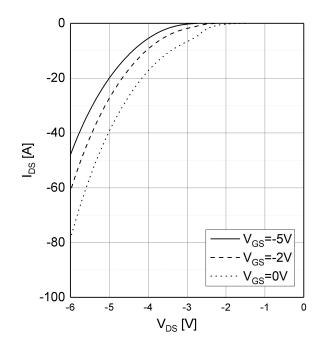
Transfer Characteristics I_{DS} =f(V_{GS}), V_{DS} =20V



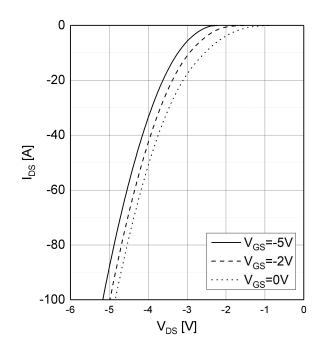
Body Diode Characteristics $I_{DS} = f(V_{DS}), T_J = 25^{\circ}C$



Body Diode Characteristics $I_{DS} = f(V_{DS})$, $T_J = -55$ °C

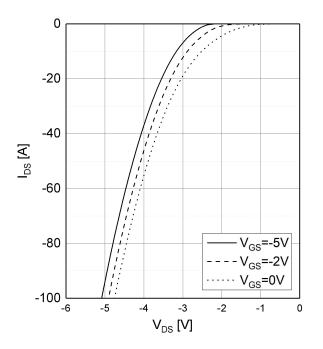


Body Diode Characteristics I_{DS} =f(V_{DS}), T_J=150°C

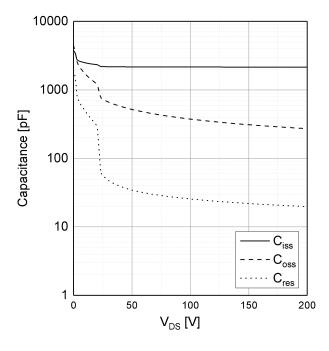




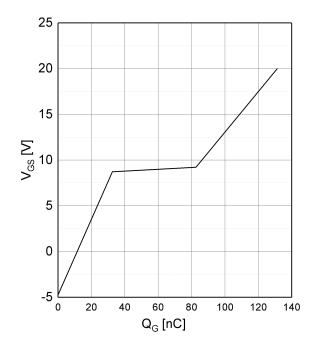
Body Diode Characteristics $I_{DS} = f(V_{DS})$, $T_J = 175$ °C



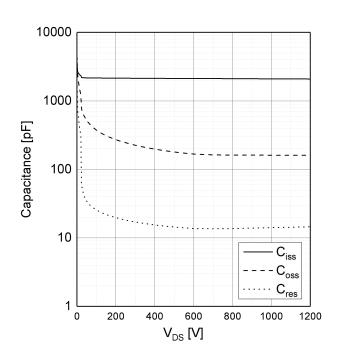
Capacitances vs Drain-Source Voltage (0-200V) $C=f(V_{DS})$, $T_j=25$ °C, $V_{AC}=25$ mV, f=100KHz



Gate Charge Characteristics V_{GS} =f(Q_G), I_{DS} =40A, V_{DS} =800V, T_J =25 $^{\circ}$ C

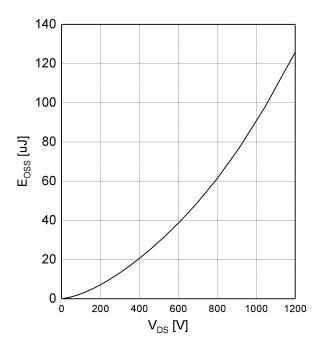


Capacitances vs Drain-Source Voltage (0-1200V) $C=f(V_{DS})$, $T_j=25^{\circ}C$, $V_{AC}=25$ mV, f=100KHz

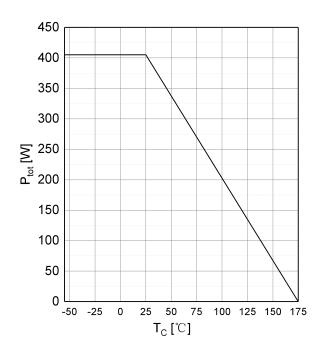




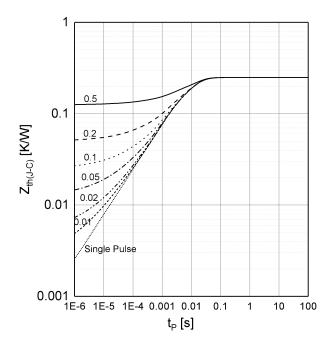
Output Capacitor Stored Energy E_{OSS} =f(V_{DS}), T_J=25°C



 $\begin{aligned} & \text{Maximum Power Dissipation Derating} \\ & P_{tot} \!=\! f(T_C), T_J \!\!\leq\! 175^{\circ} \! \text{C} \end{aligned}$



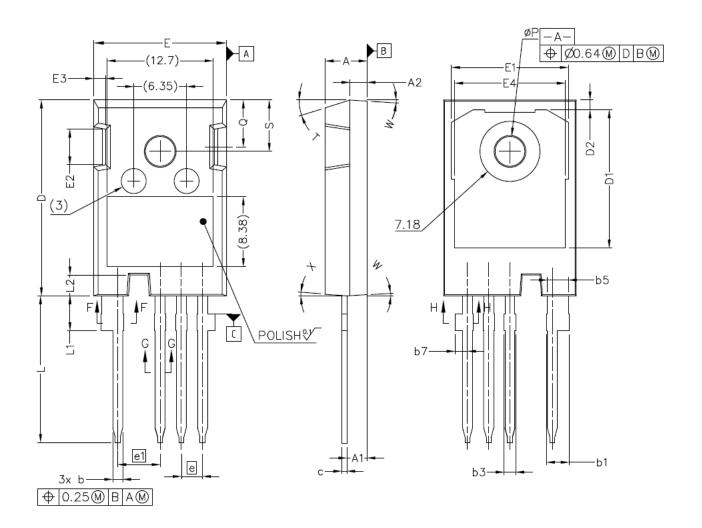
Transient Thermal Impedance (Junction to Case) $Z_{th(J-C)}=f(t)$, $T_C=25$ °C

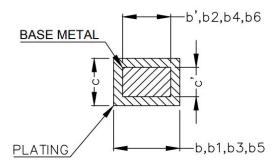




Package Dimensions

Package TO-247-4L





SECTION "F-F", "G-G" AND "H-H" SCALE: NONE



Package Dimensions

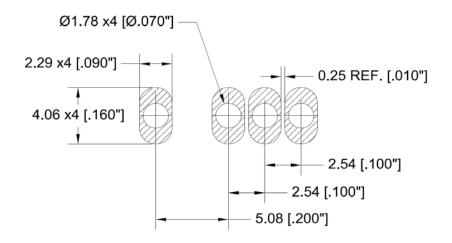
Package TO-247-4L

NOTE;

- 1. ALL METAL SURFACES: TIN PLATED, EXCEPT AREA OF CUT
- 2. DIMENSIONING & TOLERANCEING CONFIRM TO ASME Y14.5M-1994.
- 3. ALL DIMENSIONS ARE IN MILLIMETERS. ANGLES ARE IN DEGREES.
- 4. 'N' IS THE NUMBER OF TERMINAL POSITIONS

SYM	MILLIMETERS					
31111	MIN	MAX				
Α	4.83	5.21				
A1	2.29	2.54				
A2	1.91	2.16				
b`	1.07	1.28				
b	1.07	1.33				
b1	2.39	2.94				
b2	2.39	2.84				
b3	1.07	1.60				
b4	1.07	1.50				
b5	2.39	2.69				
b6	2.39	2.64				
b7	1.30	1.70				
c`	0.55	0.65				
С	0.55	0.68				
D	23.30	23.60				
D1	16.25	17.65				
D2	0.95	1.25				
E	15.75	16.13				

SYM	MILLIMETERS				
31101	MIN	MAX			
E1	13.10	14.15			
E2	3.68	5.10			
E3	1.00	1.90			
E4	12.38	13.43			
е	2.54 BSC				
e1	5.08 BSC				
Ν*	4				
L	17.31	17.82			
L1	3.97	4.37			
L2	2.35	2.65			
ØΡ	3.51	3.65			
Q	5.49 6.00				
S	6.04 6.30				
Т	17.5° REF.				
W	3.5° REF.				
Χ	4° REF.				





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